

Enhancement Mode N-Channel Power MOSFET

SOT23/NMOS/30V/ \pm 12V/1.0V/4A/39m Ω

Rev1.0





30V,39mΩ,4A, N-Channel MOSFET

1.Features

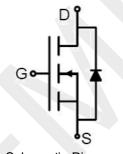
- Advanced Trench Technology
- ◆ Surface mount package

2.Applications

- ◆ Power Management
- Load Switching



VDS	RDS(on) Typ.	ID.	
	39mΩ @ 10V		
30V	42mΩ @ 4.5V	4A	
	52mΩ @ 2.5V		



Schematic Diagram

3. Package Marking and Ordering Information

Part no.	Marking	Package	PCS/Reel	PCS/CTN.	
WP3402ASS	3402A	SOT23	3,000	180,000	

4.Absolute Max Ratings at Ta=25°C (Note1)

Parameter	Symbol	Maximum	Units
Drain to Source Voltage	V _{DSS}	30	V
Gate to Source Voltage	V_{GSS}	±12	V
Drain Current (DC)	I _D	4	А
Drain Current (Pulse), PW≤300μs	I _{DP}	16	А
Total Dissipation	P_{D}	1.2	W
Junction Temperature	T_{j}	150	°C
Storage Temperature	T_{stg}	-55 to +150	°C

Note 1: Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.



5. Thermal Resistance Ratings (Note 2)

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-Ambient	$R_{ hetaJA}$	103	°C/W

Note 2: When mounted on 1 inch square copper board $t \le 10$ sec The value in any given application depends on the user's specific board design.

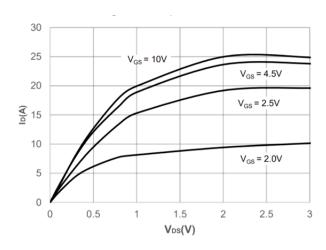
6.Electrical Characteristics at Ta=25°C (Note 3)

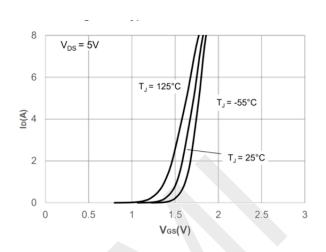
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Units
Drain to Source Breakdown Voltage	V _{(BR)DSS}	$I_D = 250 \mu A, V_{GS} = 0 V$	30	-	-	V
Zero-Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 30V, V_{GS} = 0V$	-	1	1	μΑ
Gate to Source Leakage Current	I _{GSS}	$V_{GS} = \pm 12V, V_{DS} = 0V$	-	-	±100	nA
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}$, $I_{DS}=250\mu A$	0.4	1.0	1.4	V
		V _{GS} =10V, I _D =4A	-	39	45	mΩ
Static Drain to Source On-State Resistance	R _{DS(on)}	V _{GS} =4.5V, I _D =3A		42	50	mΩ
Trodistanoc		V _{GS} =2.5V, I _D =3A	-	52	70	mΩ
Input Capacitance	C _{iss}	V _{GS} =0V,	-	414	-	pF
Output Capacitance	Coss	V _{DS} =15V,	-	36	-	pF
Reverse Transfer Capacitance	C _{rss}	Frequency=1.0MHz	-	29	-	pF
Turn-ON Delay Time	t _{d(on)}		-	4	-	ns
Rise Time	t _r	$V_{DD} = 15V, I_D = 2A,$	-	13	-	ns
Turn-OFF Delay Time	t _{d(off)}	V_{GS} =4.5V, R_{GEN} =3 Ω	-	41	-	ns
Fall Time	t _f		-	17	-	ns
	Qg	V _{DS} =15V, V _{GS} =4.5V,	-	4.5	-	nC
Total Gate Charge	Q _{gs}		-	1	-	nC
	Q_{gd}	I _D =2A	-	1	-	nC
Diode Forward Voltage	V _{FSD}	I _S =4A, V _{GS} = 0V	0.5	0.85	1.4	V

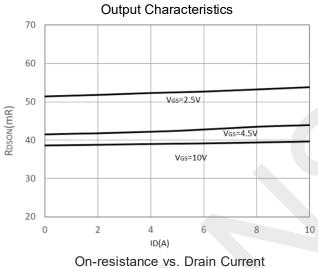
Note 3: Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

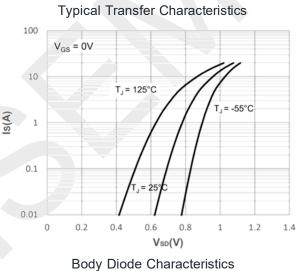


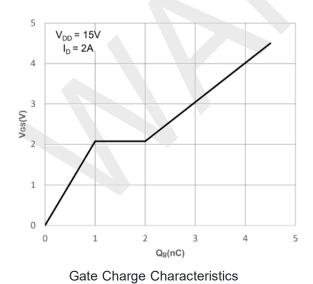
7. Typical Electrical and Thermal Characteristics

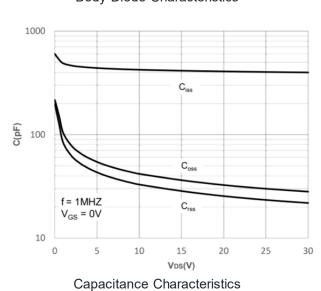




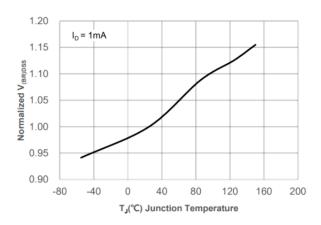






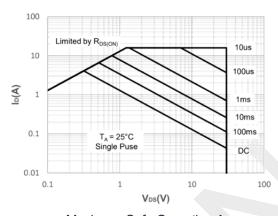




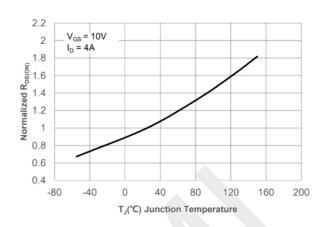


Normalized Breakdown Voltage vs.

Junction Temperature

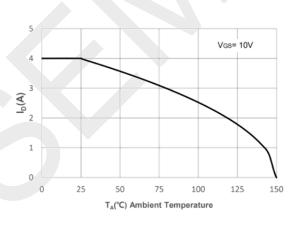


Maximum Safe Operating Area



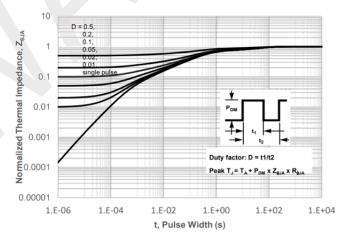
Normalized on Resistance vs.

Junction Temperature



Maximum Continuous Drain Current vs.

Case Temperature

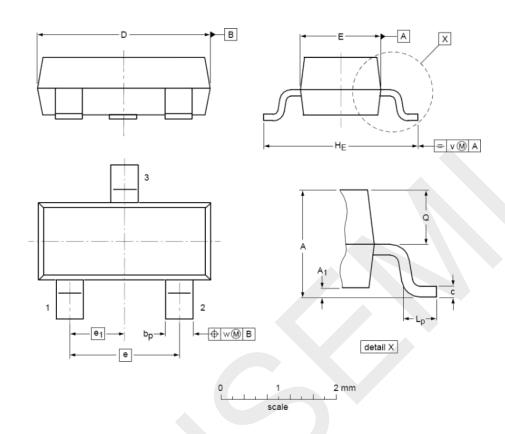


Maximum Effective Transient

Thermal Impedance, Junction-to-Case



8.Package Dimensions



DIMENSIONS (unit : mm)

Symbol	Min	Тур	Max	Symbol	Min	Тур	Max
Α	0.90	1.01	1.15	A ₁	0.01	0.05	0.10
bp	0.30	0.42	0.50	С	0.08	0.13	0.15
D	2.80	2.92	3.00	E	1.20	1.33	1.40
е		1.90		e ₁		0.95	
HE	2.25	2.40	2.55	Lp	0.30	0.42	0.50
Q	0.45	0.49	0.55	v		0.20	
w		0.10					



9.Important Notice

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